

**Search Notes**

Application/Control No.

10/630,064

Examiner

Nam V. Nguyen

Applicant(s)/Patent under  
Reexamination

CHUEY, MARK D.

Art Unit

2635

**SEARCHED**

Class	Subclass	Date	Examiner
340	825.72	2/21/2006	NN
340	825.69	2/21/2006	NN
340	825.52	2/21/2006	NN
340	825.22	2/21/2006	NN
340	3.71	2/21/2006	NN
340	5.7+	2/21/2006	NN
340	5.8+	2/21/2006	NN
340	7.55	2/21/2006	NN
340	7.56.	2/21/2006	NN
340	825.24	2/21/2006	NN
340	825.25	2/21/2006	NN
340	825.29	2/21/2006	NN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
<b>SAME AS</b>	<b>ABOVE</b>	<b>2/21/2006</b>	<b>NN</b>

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search East: USPAT; US-PUB; EPO; JPO; and Derwent. (UPDATED SEARCH)	2/21/2006	NN